Search Notes			

Application/Control No.	Applicant(s)/Patent under Reexamination
10/705,594	SINHA ET AL.
Examiner	Art Unit
Naum B. Levin	2825

	SEARCHED			
Class	Subclass	Date	Examiner	
716	4-6,8-11	3/16/2005	NL	
703	14-16	3/16/2005	N L	
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INT	INTERFERENCE SEARCHED		
Class	Subclass	Date	Examiner
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SEARC (INCLUDING SE	CH NOTES ARCH STRATEGY	)
	DATE	EXMR
see search history	3/16/2005	NL
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